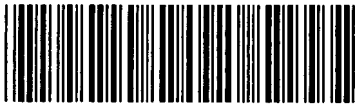


<b>Search Notes</b>  	<b>Application/Control No.</b>  10509308	<b>Applicant(s)/Patent Under Reexamination</b>  ABIKO ET AL.
	<b>Examiner</b>  Heyi, Henok G	<b>Art Unit</b>  2609

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
369	94 (text search only - see search report printout)	07/19/2007	Henok Heyi
	283 (text search only - see search report printout)	07/19/2007	Henok Heyi
428	64.4 (text search only - see search report printout)		Henok Heyi

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
I have done an exhaustive search using EAST. I conducted both text search and classified searches. I also relied upon the international search report (ISR) for prior art purposes.	07/19/2007	Henok Heyi

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>